

EDIcon 2018

The 2-Port Shunt-Thru Measurement and the Inherent Ground Loop

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Abstract

The 2-port shunt through measurement is an adaptation of 4 wire Kelvin measurement system using vector network analyzer (VNA) for measuring very low impedances, in the order of milli/micro ohms. The method is becoming popular due to its importance in measuring power distribution network (PDN) impedance. In this paper, we show the theory behind 2-port shunt through measurement using VNA and how the inherent ground loop introduces measurement error. Finally, we propose solutions for the ground loop problem with measurement results.

Author(s) Biography

Anto K Davis received a B.Tech. degree in Electrical and Electronics Engineering from the National Institute of Technology Trichy, India, in 2006, as well as M.Tech. and Ph.D. degrees in Electronics Design from the Indian Institute of Science, Bangalore, India, in 2010 and 2015 respectively. He was employed by Huawei Technologies, Bangalore, India, from 2006 - 2007, and by Brocade Communications, Bangalore, India, in 2011. He served as a postdoctoral researcher at the School of Electrical and Computer Engineering, Georgia Institute of Technology, Atlanta, USA, from January 2016 to December 2017. He is currently working as a Senior Technology Strategist at Picotest in Bangalore, India (started in January 2018).

His Ph.D. research addressed noise reduction techniques for microprocessor - power distribution networks (PDN), and methods to suppress anti-resonance peaks. Currently, he is investigating stability of switching and linear converters at Picotest. His research interests include: electromagnetic compatibility, power integrity, stability analysis of switching power converters, control of power converters, switched capacitor converters, switched inductor converters, wireless power transfer, and internet of things.

Steven M Sandler has been involved with power system engineering for nearly 40 years. The founder and CEO of Picotest.com, a company specializing in instruments and accessories for high-performance power system and distributed system testing, Steve is also the founder of AEI Systems, a company that specializes in worst-case circuit analysis for high-reliability industries.

He frequently lectures and publishes internationally on the topics of power integrity and distributed power system design. His most recent books include: *Switched-Mode Power Supply Simulation with SPICE* (2018) and *Power Integrity: Measuring, Optimizing and Troubleshooting Power-Related Parameters in Electronics Systems* (2014). Steve is a winner of the Jim Williams ACE Award for Contributor of the Year (2015) and the recipient of both the DesignCon 2017 and EDICON USA 2017 Best Paper Awards.

1 Introduction

The 2-port shunt through measurement is the gold standard for measuring milli ohm impedance while supporting measurement at very high frequency. These capabilities make it ideal for measuring power distribution network (PDN). This paper shows how to make a 2-port shunt through measurement using a commercial vector network analyzer (VNA). Unfortunately, this measurement includes an undesirable ground loop. Left uncorrected, the ground loop introduces significant errors.

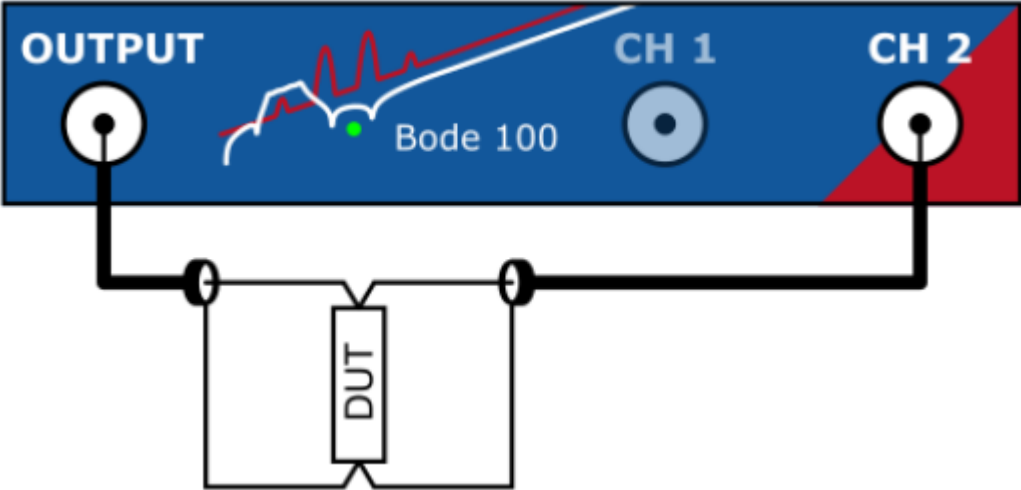


Figure 1: 2-port shunt through impedance measurement setup using a commercial VNA Omicron Bode 100 to measure low impedances ($Z_{DUT} \ll 50\Omega$).

2 Theory of two-port shunt through

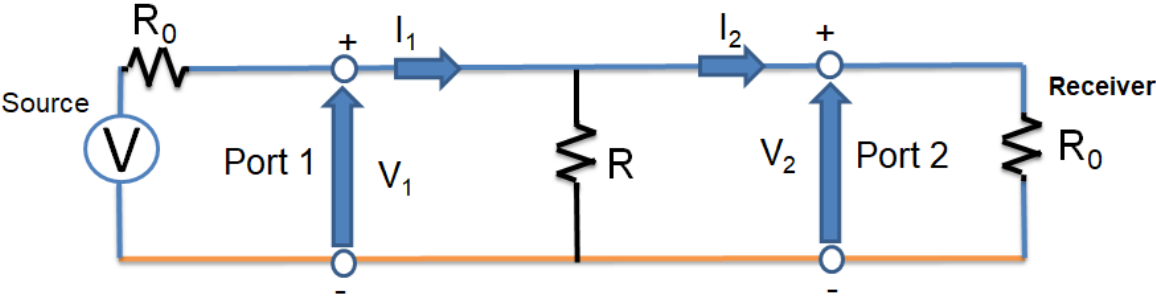


Figure 2: Equivalent circuit diagram of 2-port shunt through measurement shown in (Figure 1) to measure R.

[Figure 1](#) shows the conventional 2-port shunt through measurement set up. [Figure 2](#) shows the circuit configuration to measure a small valued resistor in 2-port shunt through measurement. From the definition of S_{21} [[1](#), pp. 2-3],

$$S_{21} = \frac{V_2 + I_2 R_0}{V_1 + I_1 R_0} = \frac{2R}{2R + R_0} \quad (1)$$

Solving for R we get,

$$R = \frac{25S_{21}}{1 - S_{21}} \simeq 25S_{21} \quad (2)$$

where it is assumed that $R_0 = 50 \Omega$ and $S_{21} \ll 1$ (True for very small impedance magnitudes/resistances - $R \ll R_0$). [Equation 1](#) is less intuitive in 2-port shunt through measurements. Another representation of the definition of S_{21} is shown in [[1](#), pp. 2],

$$S_{21} = \sqrt{\frac{\text{Power absorbed by Receiver when R is present}}{\text{Power absorbed by Receiver when R is absent}}} = \frac{2R}{2R + R_0} \quad (3)$$

[Equation 3](#) results in same value for S_{21} upon simplification. The difference here is that this gives an intuitive feeling for what is happening with S_{21} . The denominator is constant for a VNA, if the source and receiver impedances are fixed. One exception to this is proposed by Steve Sandler in his paper “Extending the usable range of the 2-port shunt through impedance measurement” [[2](#)]. Here the source R_0 is increased to shift the measurement window. Source R_0 is increased to a higher value by adding an external resistor say, 450Ω and the R_s now becomes 500Ω for a 50Ω VNA assuming that the frequency range we are interested is such that the external resistor is electrically very small and is a lumped element at that frequency. What we do here is that we reduced the maximum power that can be sourced from a VNA, which increases the range of impedances that can be measured. It should be noted that the sensitivity is an inherent property of a VNA and is not changed.

In [Equation 3](#), S_{21}^2 is the received power in Rx, scaled by the power that would have been received, if the DUT was not present. Let us look the effect of this in 2-port impedance measurements. $R = 25S_{21}$, and S_{21} increases when the received power increases.

Any increase in the received power will be reflected as an increase in the measurement of R.

3 Non-idealities

Like all measurements, the 2-port shunt through measurements suffers from non-idealities. [Figure 3](#) shows two non-idealities,

1. Cable losses
2. Ground loop

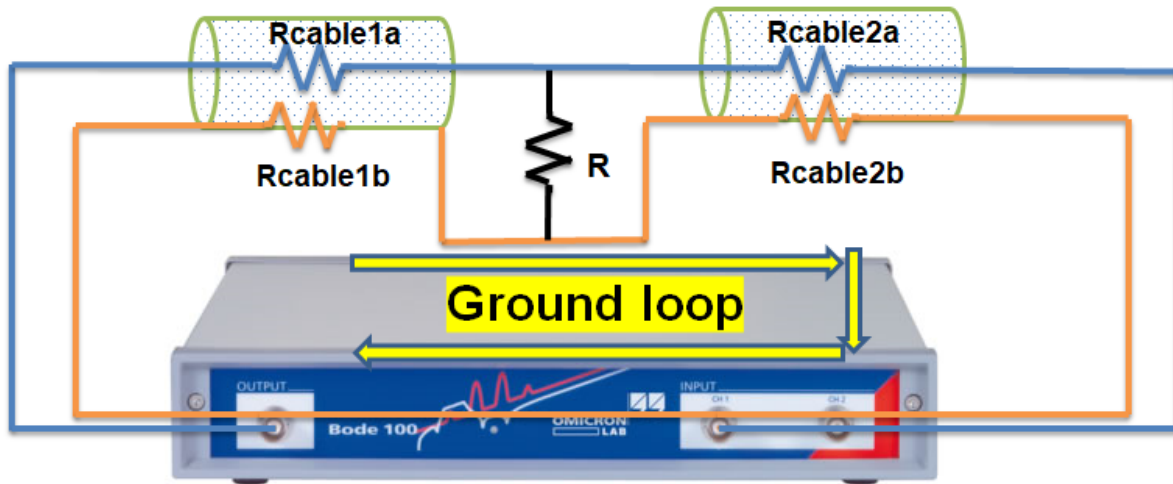


Figure 3: Non-idealities added in the 2-port shunt through measurements

Every cable will have cable losses which are marked as cable resistances in [Figure 3](#). All grounds in a VNA are connected together at the front panel RF ground. This results in a ground loop in the 2-port shunt through measurements as shown in [Figure 3](#).

4 Ground loop problem

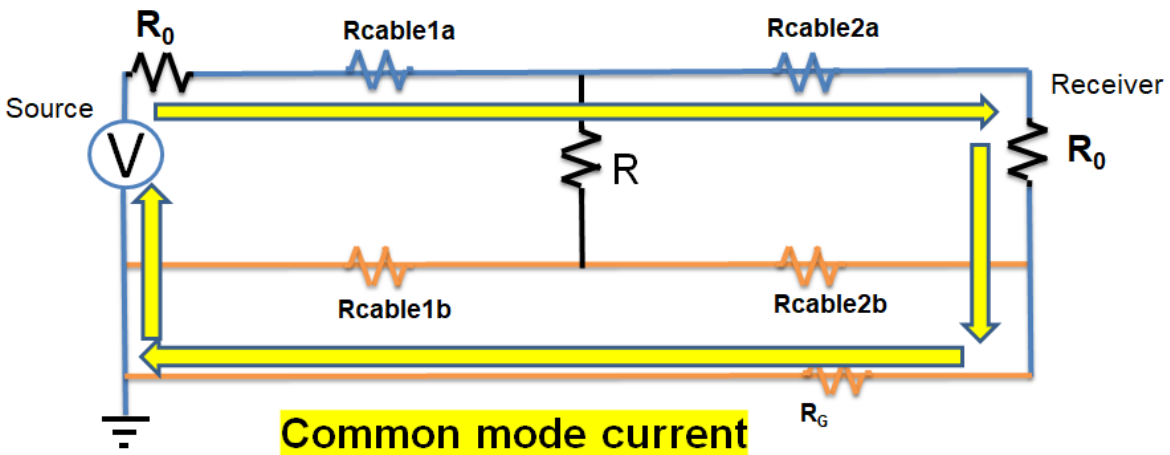


Figure 4: Common mode current formation due to the ground loop

Figure 4 shows an alternate path for signal current return seen as common mode current. The addition of ground connections created this path. If this path never existed, all the current would have returned through the cable. The new path created an additional path for current which depends upon the value of R_G . In almost all VNAs, $R_G \ll R_{cable1b}$ and $R_{cable2b}$. So, the additional current will be much larger compared to the case of not having this additional path. This additional current adds more power in the Receiver which causes to increase S_{21} and in turn the estimated R which $25S_{21}$. This is an error in measurements, and does not relate to the actual value of R. So, this will be treated as an error.

5 Example

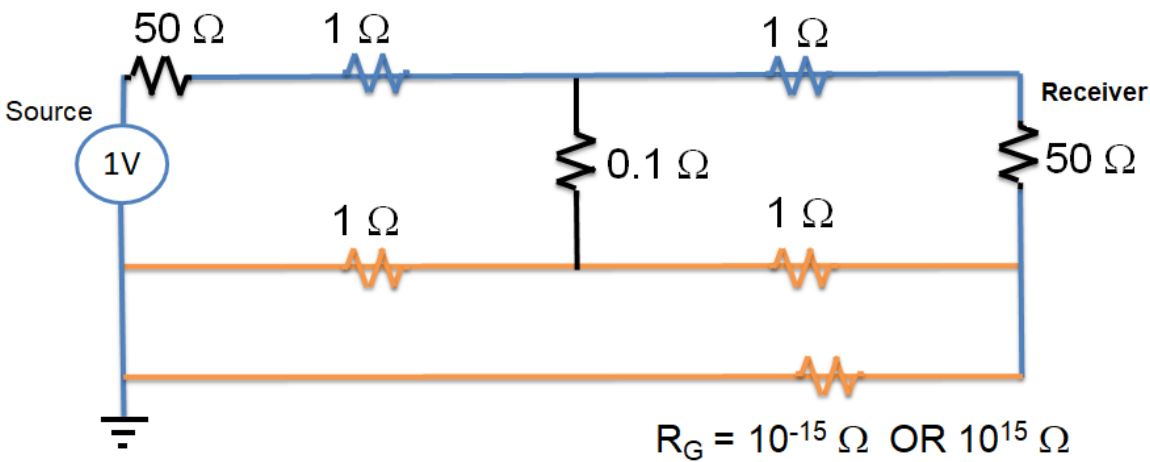


Figure 5: Example to estimate the ground loop error

Let us take an example to estimate how much error results from common mode current created by the ground loop. Figure 5 shows an example where the two cases of having and not having a ground loop is studied. A small resistance ($R_G = 10^{-15} \Omega$) is placed in the loop to mimic the ground loop connection and a large resistance ($R_G = 10^{15} \Omega$) is placed in the loop to mimic the ground loop connection. The circuit can be solved with any SPICE program to estimate the power consumed by the receiver in these two cases,

1. $R_G = 10^{-15} \Omega$
2. $R_G = 10^{15} \Omega$

We can use Equation 3, to estimate the S_{21} . The denominator, Power absorbed by Rx when DUT is absent = 5 mW (cable losses are neglected and is assumed that no port extension through calibration) is the maximum power that can be transferred from the source. This is a constant with respect to a VNA. The S_{21} for these two cases are,

1. $S_{21} = \frac{2.539751 \mu W}{5 mW} = 0.022538$

$$2. S_{21} = \frac{67.861312nW}{5mW} = 0.0036841$$

As we expected in case 1, there is more power consumed by the Receiver due to the higher common mode current. The estimated R from S_{21} based on $R = 25S_{21}$ are,

1. $S_{21} = 0.56344$
2. $S_{21} = 0.092101$

The error due to ground loop is nearly 460 %. The small deviation in case 2 comes from our approximations and assumptions. The example was done for DC. The same approach can be performed for AC case too. This is left to the interested readers.

It is clear from this example that we need to **minimize the common mode current** which contributes large error in 2-port shunt through measurements.

6 Solutions to ground loop problem

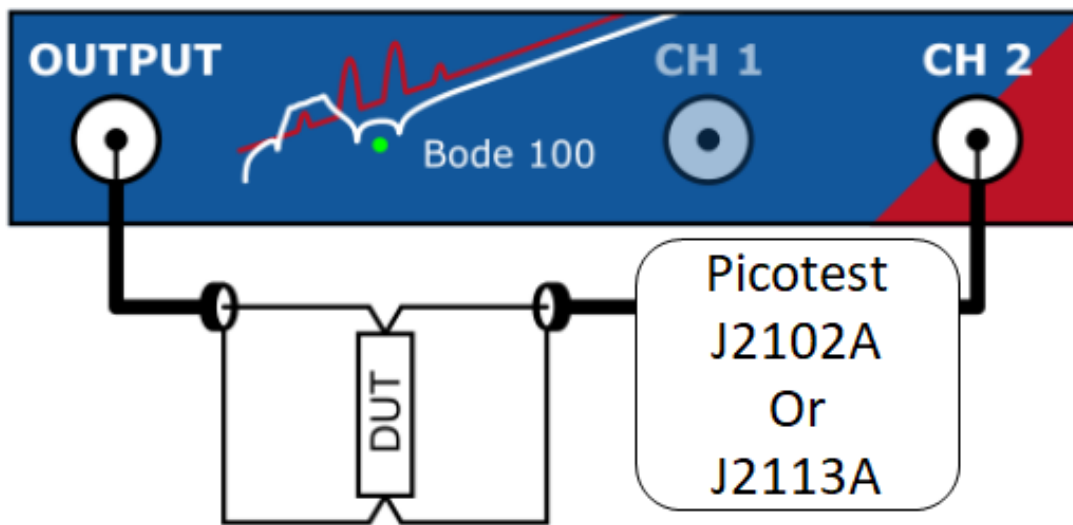


Figure 6: Removing ground loop in 2-port shunt through impedance measurement setup shown in [Figure 1](#).

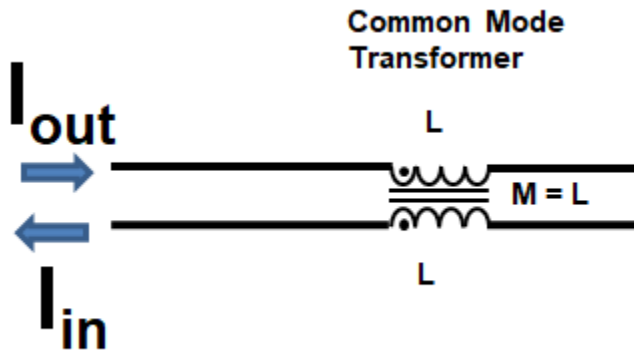


Figure 7: Common mode transformer circuit

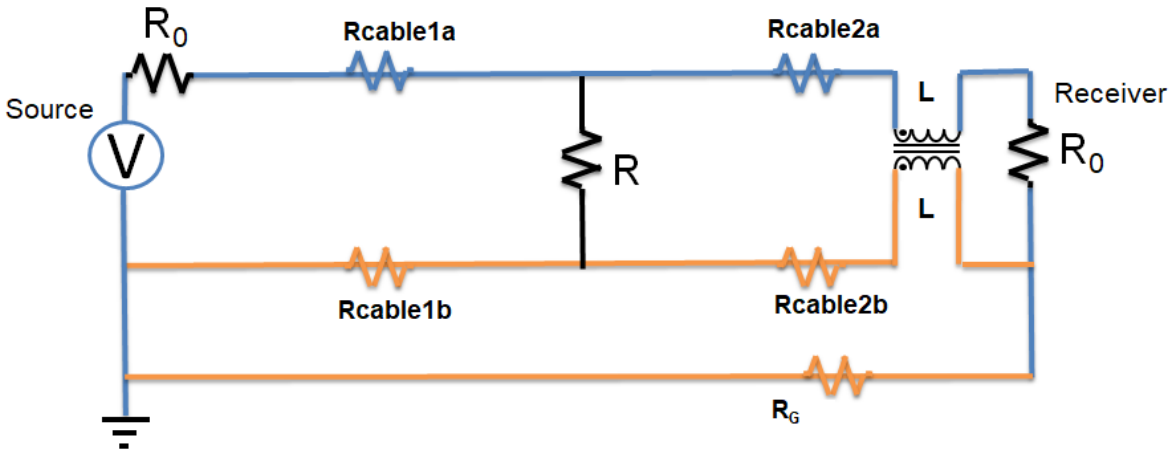
[Figure 6](#) shows the solution to ground loop problem. The obvious way to minimize the measurement error is by minimizing the common mode current. Picotest has two solutions to minimize common mode current

1. Common mode choke - J2102A
2. Semi-Floating Differential Amplifier - J2113A

[Figure 10](#) shows the experimental results with the two Picotest solutions. The explanation to the working principle underlying these two solutions are shown in the next two subsections.

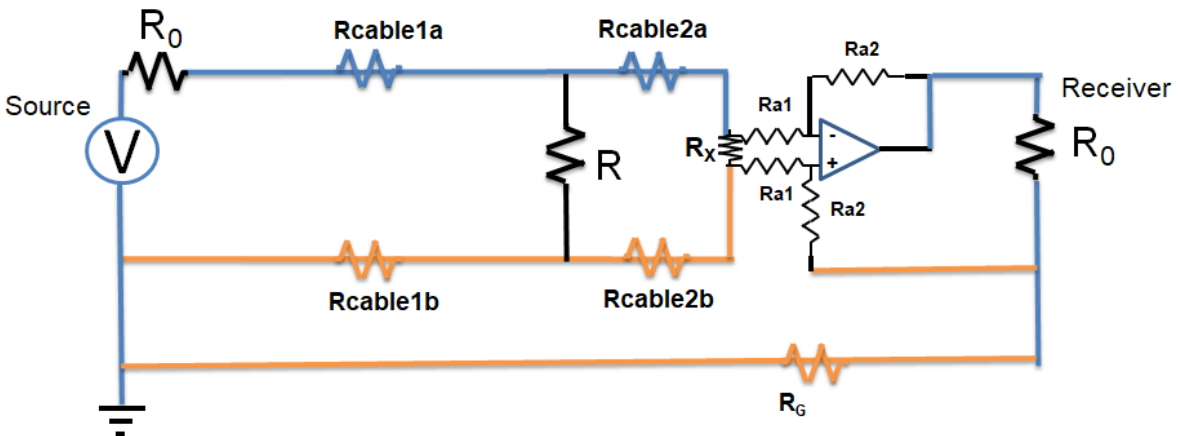
6.1 Common mode choke - J2102A

One solution to the ground loop problem is by introducing a high quality 50Ω common mode transformer or common mode choke. As the name indicates, it blocks common mode current. [Figure 7](#) shows the equivalent circuit of a common mode transformer. The common mode transformer is wound on a ferrite core such that when $I_{out} = I_{in}$, the inductance offered to the current flow is zero. The part of this current is called as differential current. This is the current that contributes to the normal operation. When a part of the current which flows through one and does not return through the other it is called as common mode current. The common mode transformer shows a very large inductance to this current flow and effectively blocks this. The amount of blocking known as attenuation highly depends upon the design of the transformer. Since this transformer should not affect the normal operation (VNA measurement operation), it has to be designed such that the impedance seen by the differential current is 50Ω. **An important consideration is that the common mode choke is not effective at DC or low frequency.** Practical measurements show that Picotest J2102A works at frequencies above 3 kHz. The maximum frequency at which the common mode transformer is effective depends upon the core and is determined by the quality of the material. Better measurement results are observed when J2102A is connected in receiver loop as shown in [Figure 8](#).



Common mode current faces large inductance L

Figure 8: Common mode transformer (J2102A) included in two-port shunt through measurement circuit



Common mode current faces large resistance $R_{a1} + R_{a2}$

Figure 9: Semi-floating differential amplifier (J2113A) included in two-port shunt through measurement circuit

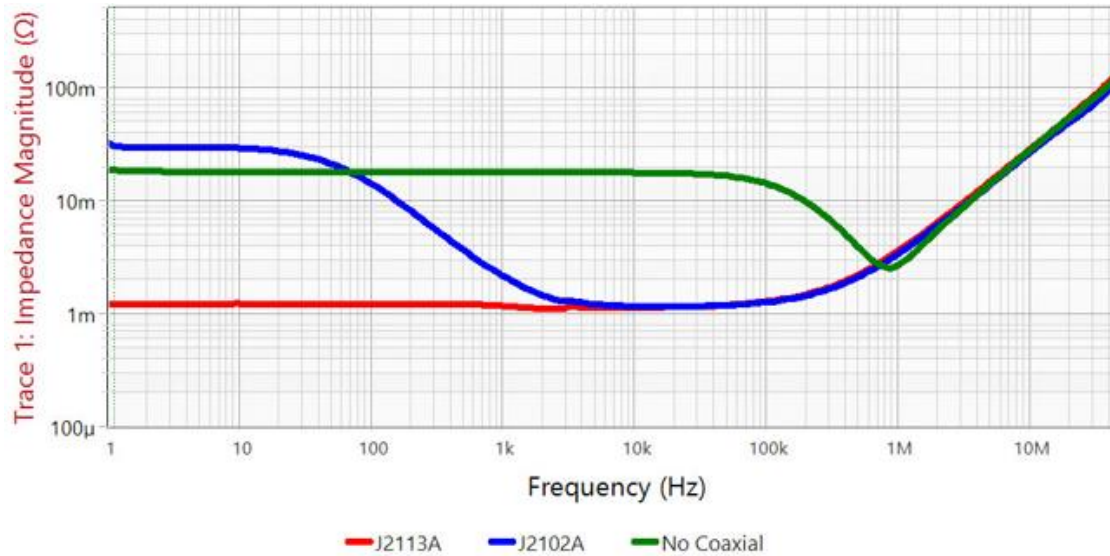


Figure 10: Comparisons of Picotest solutions for ground loop problem in 2-port shunt through impedance measurements while measuring a $1m\Omega$ resistance

6.2 Semi-floating differential amplifier - J2113A

Another solution to the ground loop problem is the semi-floating differential amplifier. The semi-floating differential amplifier shows large resistance to common mode current. Because it is resistance, semi-floating amplifier is effective at DC too. Better measurement results are observed when J2113A is connected in receiver loop as shown in [Figure 9](#).

7 Conclusion

The two-port shunt through is an important measurement method to measure very low impedances. As the PDN impedances that need to be measured is decreasing based on the higher chip functionality requirements, the method is gaining popular. Currently, the commonly designed PDN target impedance is in the milli ohm range. Some of the advanced PDN designs are in the range of micro ohm. This makes the two-port shunt through measurement an important method for PDN designs.

Unfortunately, the 2-port shunt through measurement topology has an inherent ground loop. This paper studied the reason for this ground loop with an example. The solution to solve this problem is by breaking the ground loop. Two methods (common mode choke or semi-floating differential amplifier) to break ground loop are proposed in this paper. The common mode choke is not effective at DC while a semi-floating differential amplifier is an effective solution even at DC. Measurement results for both these proposed solutions are presented in this paper to prove the effectiveness of these methods. Accurate PDN measurements require ground loop isolation with flat frequency characteristics and uniform $50\ \Omega$ impedance. General purpose or home-made

solutions may not provide the flat, 50Ohm impedance required. Verify your isolator, or use one made specifically for this purpose.

Note that one way to help reduce the impact of the ground loop is to minimize the resistance in the ground connections from the VNA to the DUT.

References

- [1] R. W. Anderson, "S-parameter techniques for faster, more accurate network design," *HP application note 95-1*, Feb. 1967.
- [2] S. M. Sandler, "Extending the usable range of the 2-port shunt through impedance measurement," *IEEE MTT-S Lat. Am. Microw. Conf. (LAMC)*, pp. 1–3, Dec 2016.
- [3] J. Y. Choi and I. Novak, "Simulating and Measuring Microohms in PDNs", DesignCon 2015